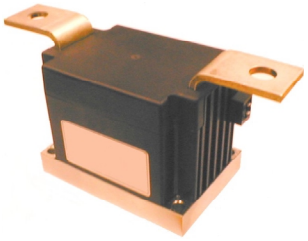
IXYS



Date: 11.01.2006

Data Sheet Issue: 1

Phase Control Thyristor Module
Types MCO740-20io1 to MCO740-22io1

Absolute Maximum Ratings

V_{RRM} V_{DRM} [V]	Type
2000	MCO740-20io1
2200	MCO740-22io1

	VOLTAGE RATINGS	MAXIMUM LIMITS	UNITS
V_{DRM}	Repetitive peak off-state voltage [1]	2000-2200	V
V_{DSM}	Non-repetitive peak off-state voltage [1]	2000-2200	V
V_{RRM}	Repetitive peak reverse voltage [1]	2000-2200	V
V_{RSM}	Non-repetitive peak reverse voltage [1]	2100-2300	V

	OTHER RATINGS		MAXIMUM LIMITS	UNITS
$I_{T(AV)M}$	Maximum average on-state current, T_c=55°C [2]		1190	
$I_{T(AV)M}$	Maximum average on-state current, T_c=88°C [2]		740	
$I_{T(AV)M}$	Maximum average on-state current. T_c=85°C [2]		793	A
$I_{T(RMS)M}$	Nominal RMS on-state current, T_c=25°C [2]		2389	
$I_{T(d.c.)}$	D.C. on-state current, T_c=25°C [2]		1978	
I_{TSM}	Peak non-repetitive surge t_p=10ms, V_{rm}=60%V_{RRM} [3]		32.7	kA
I_{TSM2}	Peak non-repetitive surge t_p=10ms, V_{rm}≤10V [3]		36.0	kA
I^2t	I^2t capacity for fusing t_p=10ms, V_{rm}=60%V_{RRM} [3]		5.35×10^6	A^2s
I^2t	I^2t capacity for fusing t_p=10ms, V_{rm}≤10V [3]		6.48×10^6	A^2s
$(di/dt)_{cr}$	Critical rate of rise of on-state current [4]	(continuous, 50Hz)	75	A/µs
		(repetitive, 50Hz, 60s)	150	
		(non-repetitive)	300	
V_{RGM}	Peak reverse gate voltage		5	V
$P_{G(AV)}$	Mean forward gate power		4	W
P_{GM}	Peak forward gate power		30	W
V_{ISOL}	Isolation Voltage [5]		3500	V
$T_{Vj\ op}$	Operating temperature range		-40 to +125	°C
T_{stg}	Storage temperature range		-40 to +150	°C

Notes:

1) De-rating factor of 0.13% per °C is applicable for T_{vj} below 25°C.
2) Single phase; 50 Hz, 180° half-sinewave.
3) Half-sinewave, 125°C T_{vj} initial.
4) V_D = 67% V_{DRM}, I_{FG} = 2 A, $t_r \leq$ 0.5µs, T_C = 125°C.
5) AC RMS voltage, 50 Hz, 1min test

Characteristics

	PARAMETER	MIN.	TYP.	MAX.	TEST CONDITIONS [1]	UNITS
V_{TM}	Maximum peak on-state voltage	-	-	1.45	I_{TM}=2220A	V
		-	-	1.65	I_{TM}=3000A	V
V_{T0}	Threshold voltage	-	-	0.833		V
r_T	Slope resistance	-	-	0.210		mΩ
$(dv/dt)_{cr}$	Critical rate of rise of off-state voltage	1000	-	-	V_D = 80% V_{DRM}, linear ramp, Gate o/c	V/µs
I_{DRM}	Peak off-state current	-	-	2	Rated V_{DRM}, T_j=25°C	mA
		-	-	100	Rated V_{DRM}	
I_{RRM}	Peak reverse current	-	-	2	Rated V_{RRM}, T_j=25°C	
		-	-	100	Rated V_{RRM}	
V_{GT}	Gate trigger voltage	-	-	2.5	T_{vj} = 25°C, V_D = 10 V, I_T = 3 A	V
I_{GT}	Gate trigger current	-	-	250		mA
I_H	Holding current	-	-	450	T_{vj} = 25°C	mA
I_L	Latching current	-	-	1000	T_{vj} = 25°C	mA
t_{gd}	Gate controlled turn-on delay time	-	0.8	2.0	V_D=67% V_{DRM}, I_T=2000A, di/dt=10A/µs, I_{FG}=2A, t_r=0.5µs, T_j=25°C	µs
t_{gt}	Turn-on time	-	1.4	3.0		
Q_{rr}	Recovered Charge	-	4000	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V	µC
Q_{ra}	Recovered Charge, 50% chord	-	2300	2600		µC
I_{rm}	Reverse recovery current	-	155	-		A
t_{rr}	Reverse recovery time, 50% chord	-	30	-		µs
t_q	Turn-off time	-	375	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V, V_{dr}=80%V_{DRM}, dV_{dr}/dt=20V/µs	µs
		-	650	-	I_{TM}=1000A, t_p=1000µs, di/dt=10A/µs, V_r=50V, V_{dr}=80%V_{DRM}, dV_{dr}/dt=200V/µs	
R_{thJC}	Thermal resistance, junction to case	-	-	0.0405		K/W
R_{thCH}	Thermal resistance, case to heatsink	-	-	0.0100		K/W
F_1	Mounting torque (to heatsink)	5.1	-	6.9		Nm
F_2	Mounting torque (to terminals)	16.2	-	19.8		Nm
W_t	Weight	-	2.2	-		kg

Notes:

1) Unless otherwise indicated T_{vj}=125°C.

Notes on Ratings and Characteristics

1.0 Voltage Grade Table

Voltage Grade	V_{DRM} V_{DSM} V_{RRM} V	V_{RSM} V	V_D V_R DC V
20	2000	2100	1250
22	2200	2300	1350

2.0 Extension of Voltage Grades

This report is applicable to other voltage grades when supply has been agreed by Sales/Production.

3.0 De-rating Factor

A blocking voltage de-rating factor of 0.13%/°C is applicable to this device for T_{vj} below 25°C.

4.0 Repetitive dv/dt

Standard dv/dt is 1000V/µs.

5.0 Snubber Components

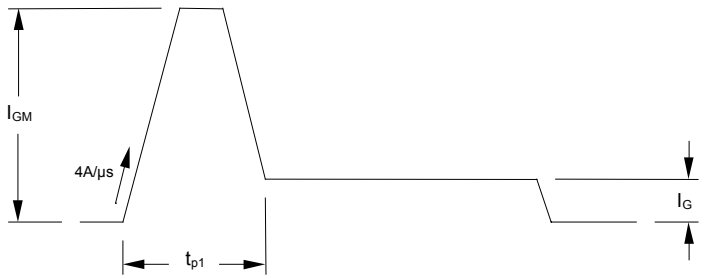
When selecting snubber components, care must be taken not to use excessively large values of snubber capacitor or excessively small values of snubber resistor. Such excessive component values may lead to device damage due to the large resultant values of snubber discharge current. If required, please consult the factory for assistance.

6.0 Rate of rise of on-state current

The maximum un-primed rate of rise of on-state current must not exceed 300A/µs at any time during turn-on on a non-repetitive basis. For repetitive performance, the on-state rate of rise of current must not exceed 150A/µs at any time during turn-on. Note that these values of rate of rise of current apply to the total device current including that from any local snubber network.

7.0 Gate Drive

The nominal requirement for a typical gate drive is illustrated below. An open circuit voltage of at least 30V is assumed. This gate drive must be applied when using the full di/dt capability of the device.



The magnitude of I_{GM} should be between five and ten times I_{GT}, which is shown on page 2. Its duration (t_{p1}) should be 20µs or sufficient to allow the anode current to reach ten times I_L, whichever is greater. Otherwise, an increase in pulse current could be needed to supply the necessary charge to trigger. The 'back-porch' current I_G should remain flowing for the same duration as the anode current and have a magnitude in the order of 1.5 times I_{GT}.

8.0 Computer Modelling Parameters

8.1 Thyristor dissipation calculations

$$I_{AV} = \frac{-V_{T0} + \sqrt{V_{T0}{}^2 + 4 \cdot ff^2 \cdot r_T \cdot W_{AV}}}{2 \cdot ff^2 \cdot r_T}$$

and:

$$W_{AV} = \frac{\Delta T}{R_{th}}$$

$$\Delta T = T_{j\max} - T_C$$

Where V_{T0} = 0.833 V, r_T = 0.21 mΩ.

R_{th} = Supplementary thermal impedance, see table below and

ff = Form factor, see table below.

Supplementary Thermal Impedance (Junction to Case)							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	0.0456	0.0449	0.0440	0.0433	0.0423	0.0411	0.0405
Sine wave	0.0448	0.0439	0.0431	0.0421	0.0409		

Form Factors							
Conduction Angle	30°	60°	90°	120°	180°	270°	d.c.
Square wave	3.464	2.449	2	1.732	1.414	1.149	1
Sine wave	3.98	2.778	2.22	1.879	1.57		

8.2 Calculating thyristor V_T using ABCD coefficients – For loss calculations

The on-state characteristic, I_T vs. V_T, is represented in two ways;
(i) the well established V_{T0} and r_T tangent used for rating purposes and
(ii) a set of constants A, B, C, D, forming the coefficients of the representative equation for V_T in terms of I_T given below:

$$V_T = A + B \cdot \ln(I_T) + C \cdot I_T + D \cdot \sqrt{I_T}$$

The constants, derived by curve fitting software, are given below for both hot and cold characteristics. The resulting values for V_T agree with the true device characteristic over a current range, which is limited to that plotted.

25°C Coefficients		125°C Coefficients	
A	0.7730476	A	-0.2378519
B	0.07410681	B	0.2685822
C	1.691121×10^{-4}	C	3.595580×10^{-4}
D	-7.725044×10^{-3}	D	-0.02813815

8.3 D.C. Thermal Impedance Calculation

$$r_t = \sum_{p=1}^{p=n} r_p \cdot \left(1 - e^{\frac{-t}{\tau_p}}\right)$$

Where *p* = *1* to *n*

n = number of terms in the series and
t = Duration of heating pulse in seconds.
r_t = Thermal resistance at time t.
r_p = Amplitude of p_{th} term.
τ_p = Time Constant of r_{th} term.

The coefficients for this device are shown in the tables below:

D.C. Junction to Case						
Term	1	2	3	4	5	6
r_p	1.0×10^{-5}	0.016708	0.018317	4.346771×10^{-3}	1.004820×10^{-3}	1.0×10^{-5}
τ_p	2.460066	0.999836	21.998376	9.793053×10^{-3}	2.003674	5.007343

9.0 Reverse recovery ratings

(i) Q_{ra} is based on 50% I_{RM} chord as shown in Fig. 1

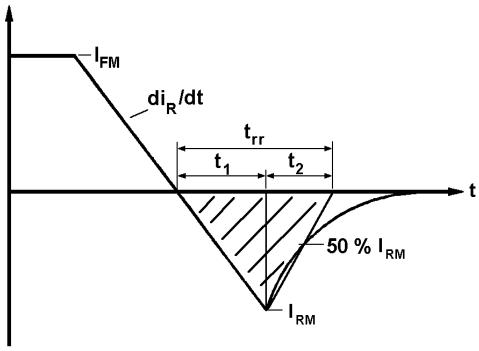


Fig. 1

(ii) Q_{rr} is based on a 150 µs integration time i.e.

$$Q_{rr} = \int_0^{150\,\mu s} i_{rr}.dt$$

(iii)

$$K\ Factor = \frac{t_1}{t_2}$$

Curves

Figure 1 – On-state characteristics of Limit device

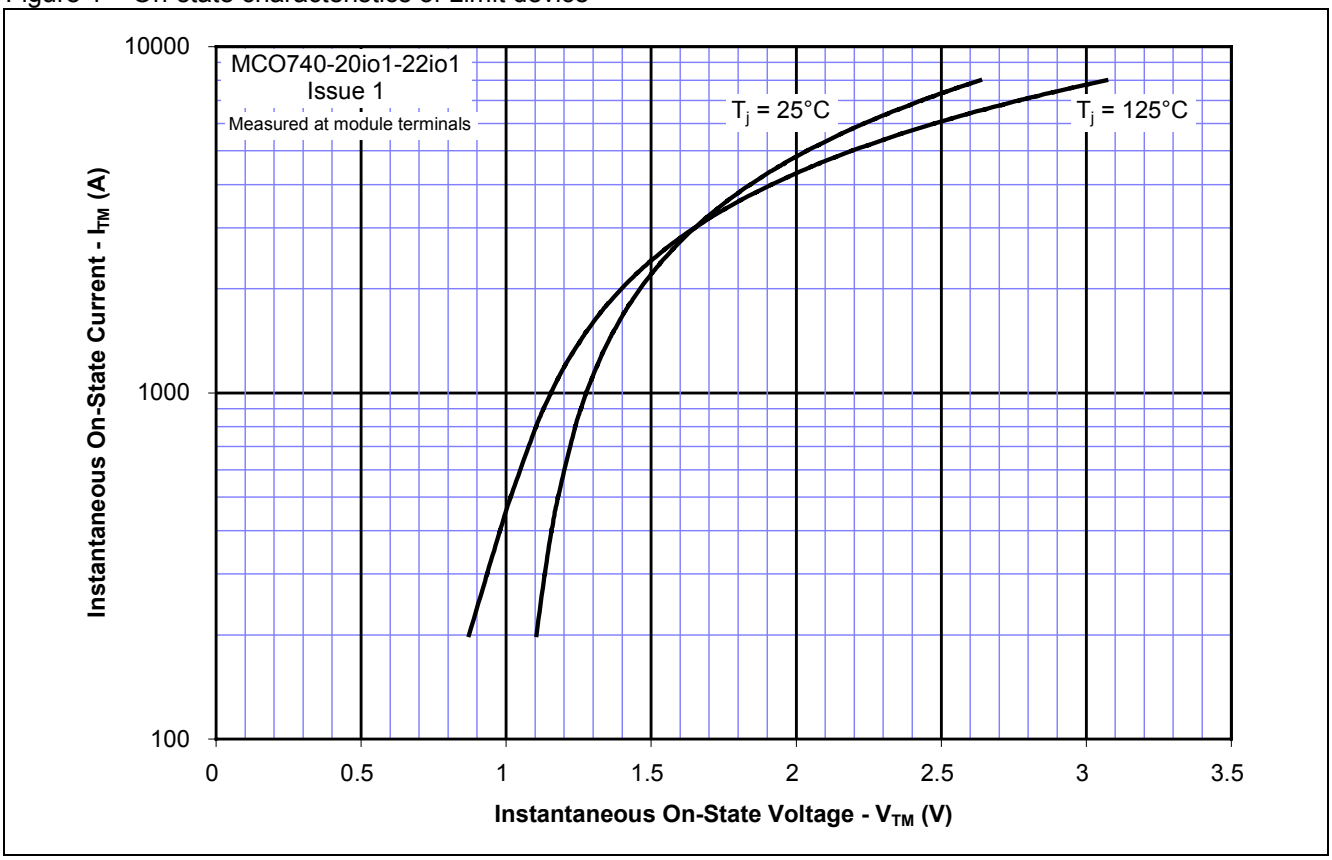


Figure 2 – Gate characteristics – Trigger limits

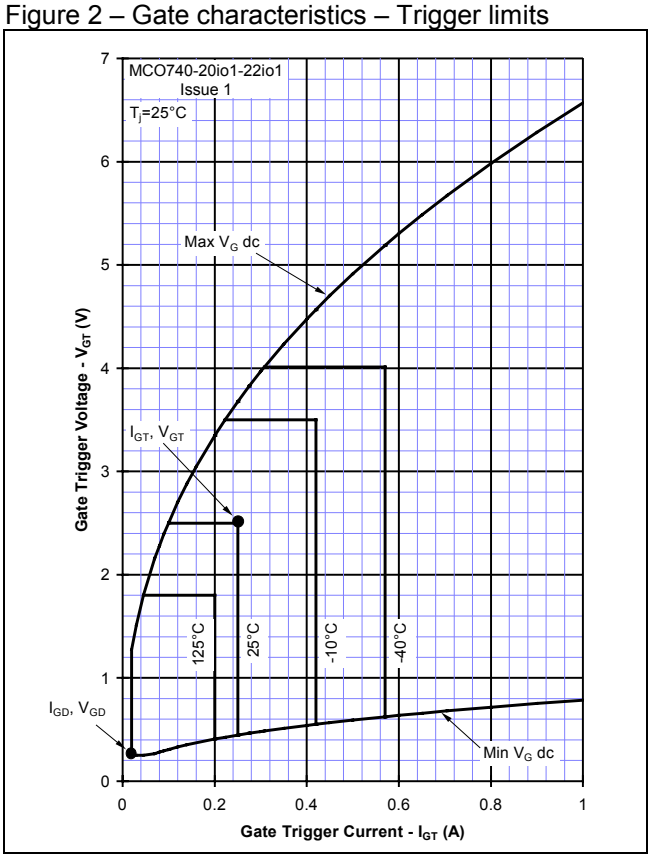


Figure 3 – Gate characteristics – Power curves

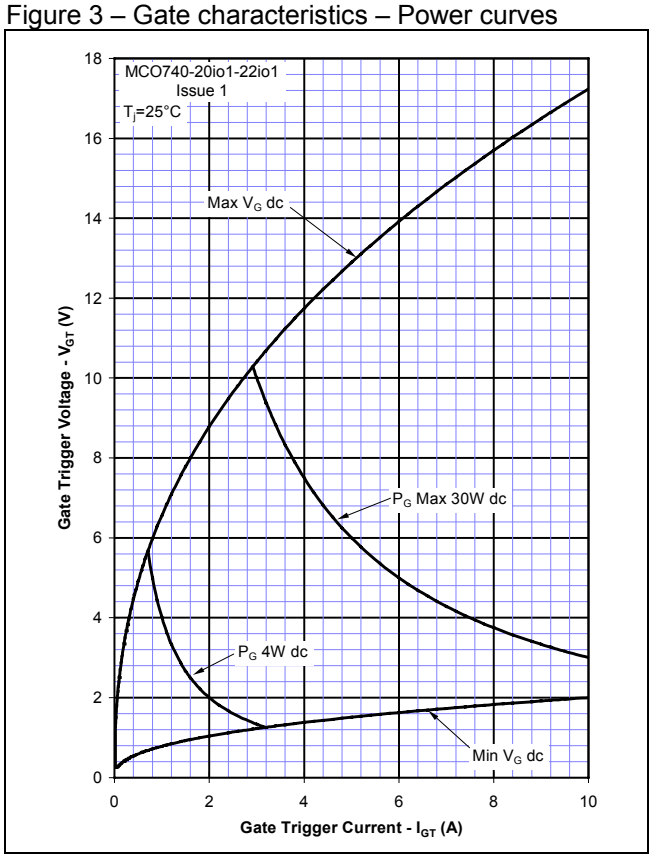


Figure 4 – Total recovered charge, Q_{rr}

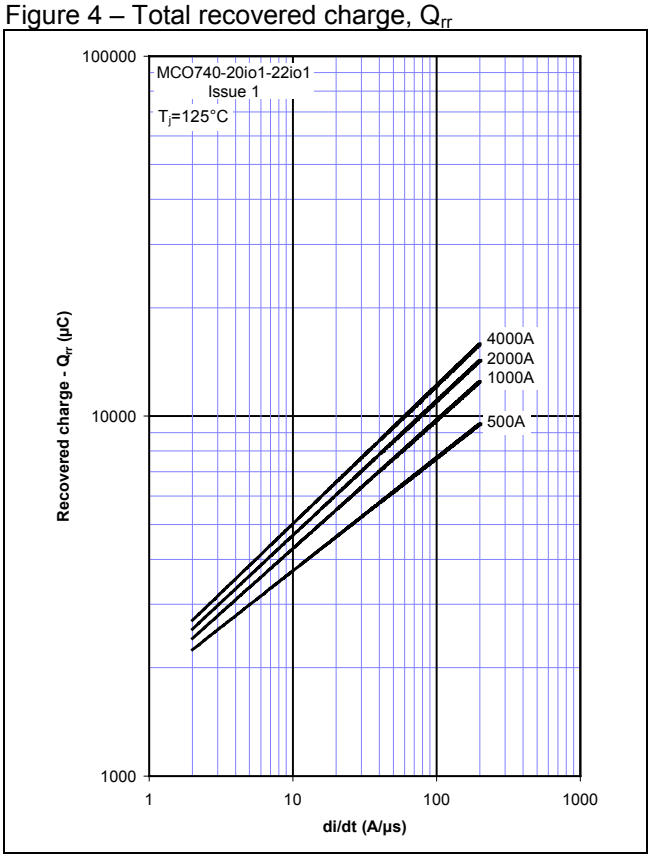


Figure 5 – Recovered charge, Q_{ra} (50% chord)

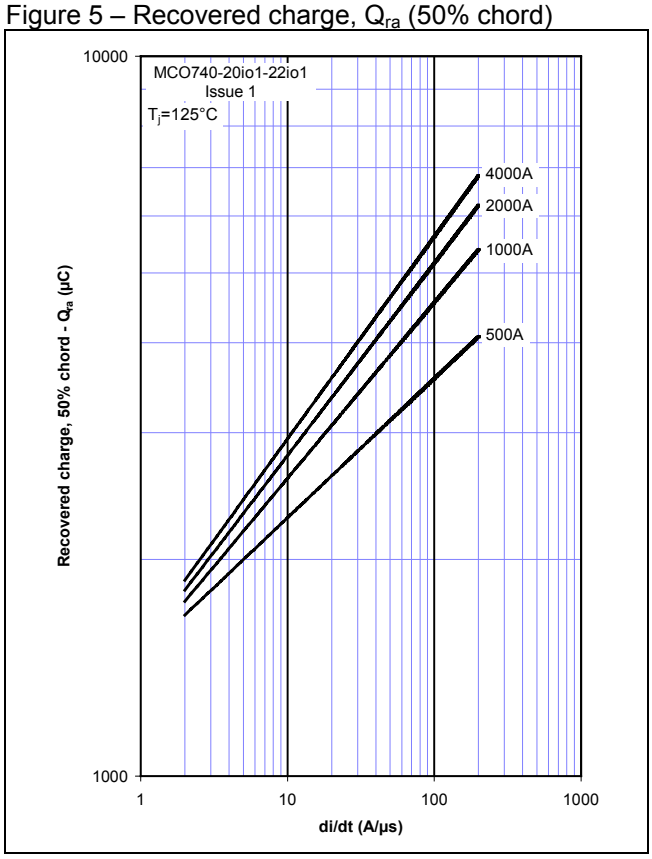


Figure 6 – Peak reverse recovery current, I_{rm}

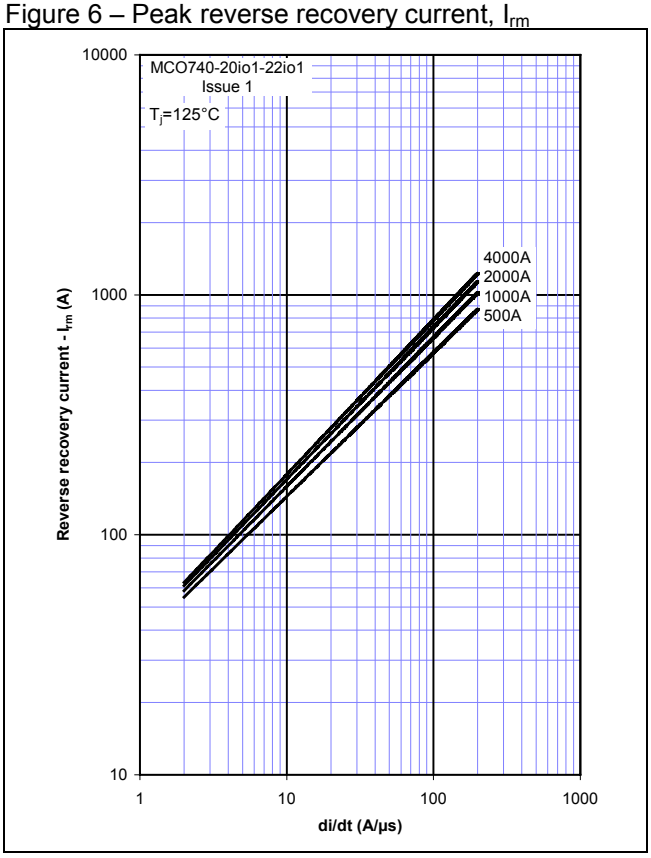


Figure 7 – Maximum recovery time, t_{rr} (50% chord)

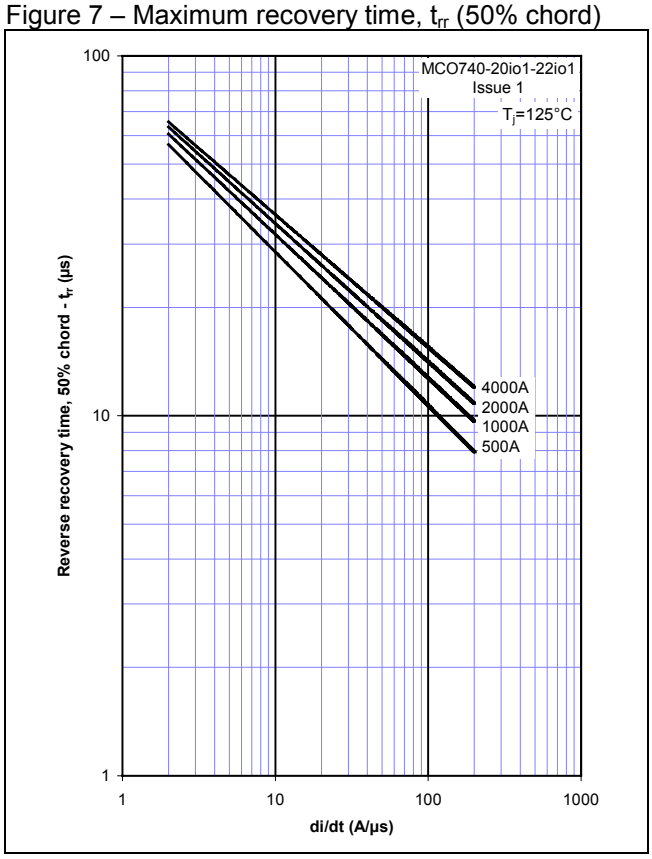


Figure 8 – On-state current vs. Power dissipation – Sine wave

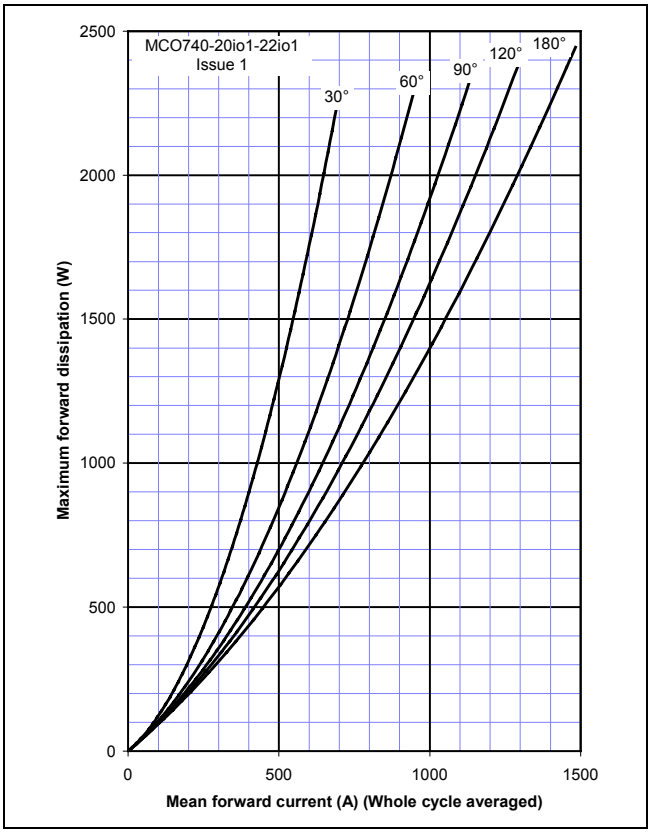


Figure 9 – On-state current vs. Heatsink temperature – Sine wave

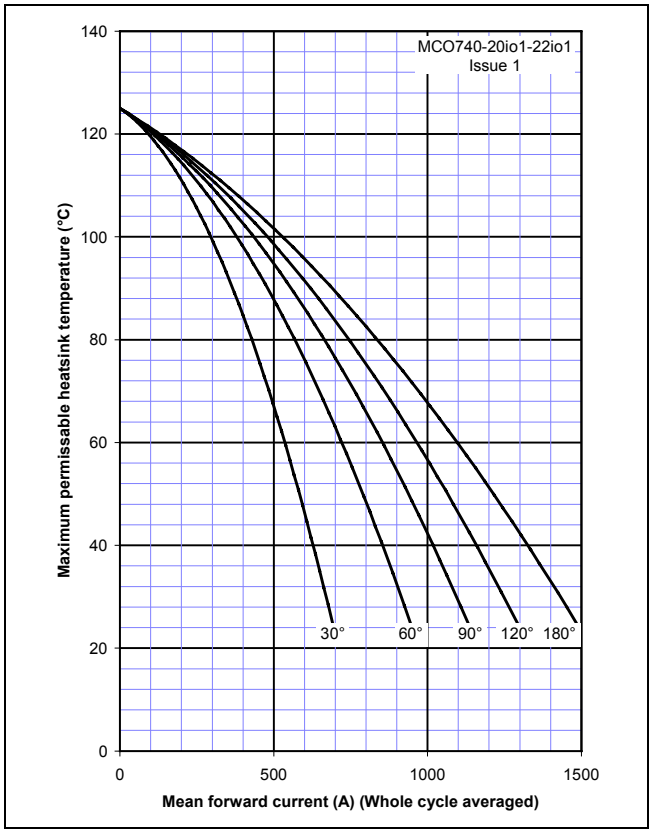


Figure 10 – On-state current vs. Power dissipation – Square wave

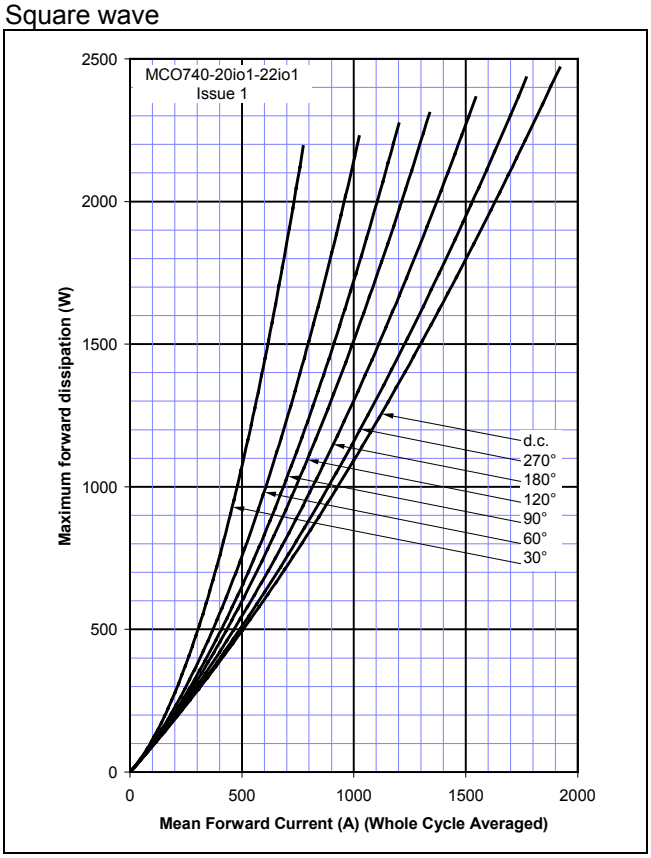


Figure 11 – On-state current vs. Heatsink temperature – Square wave

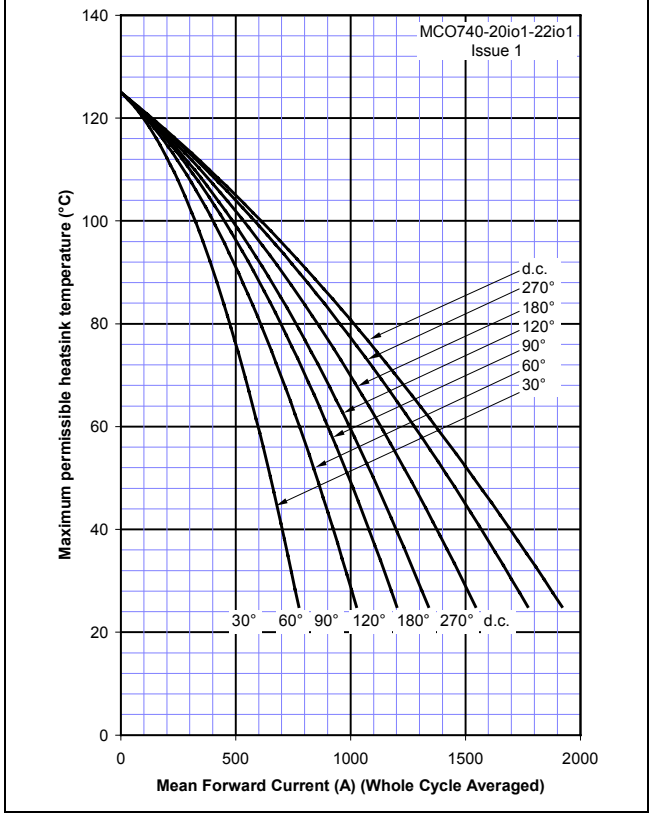


Figure 12 – Maximum surge and I^2t Ratings

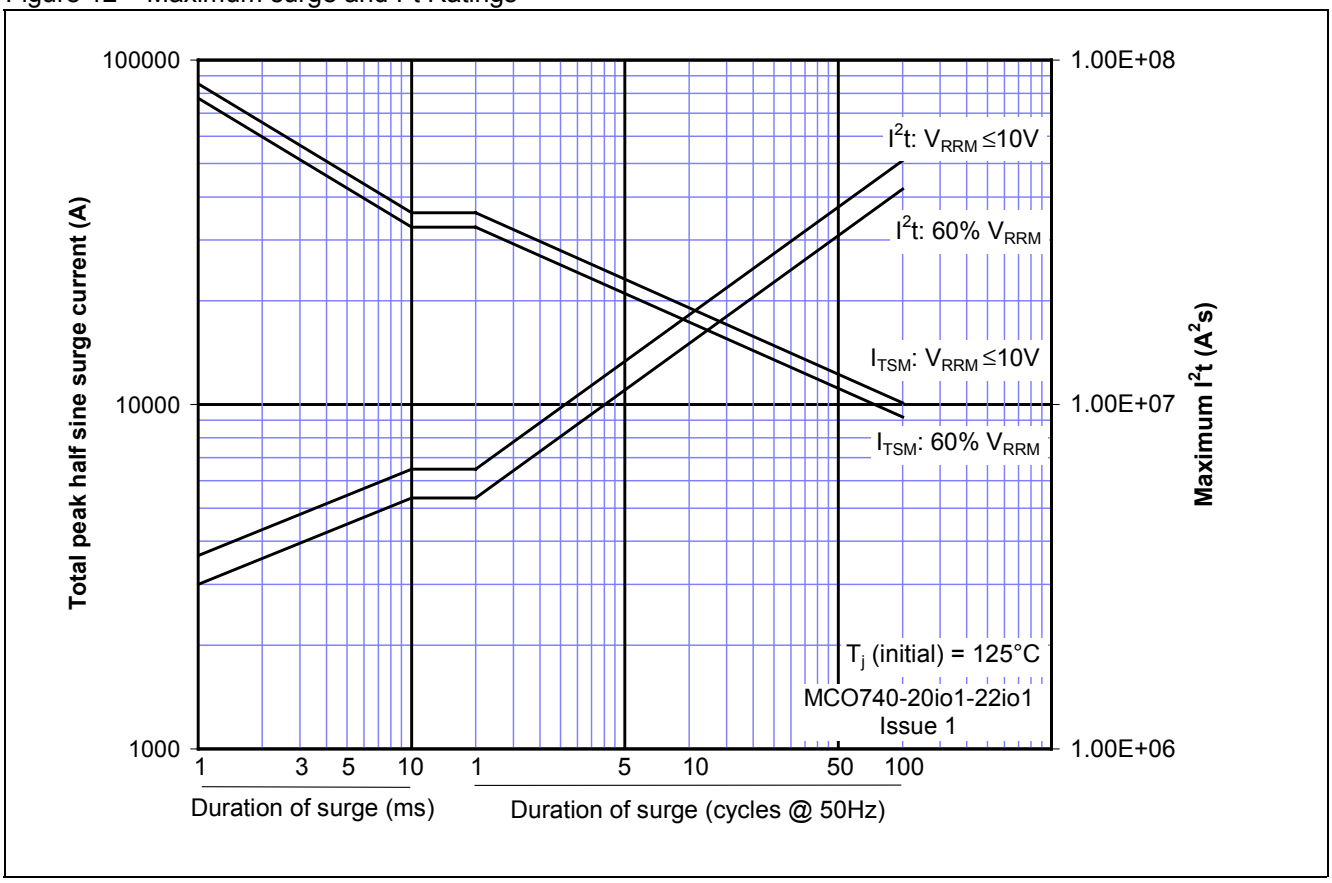
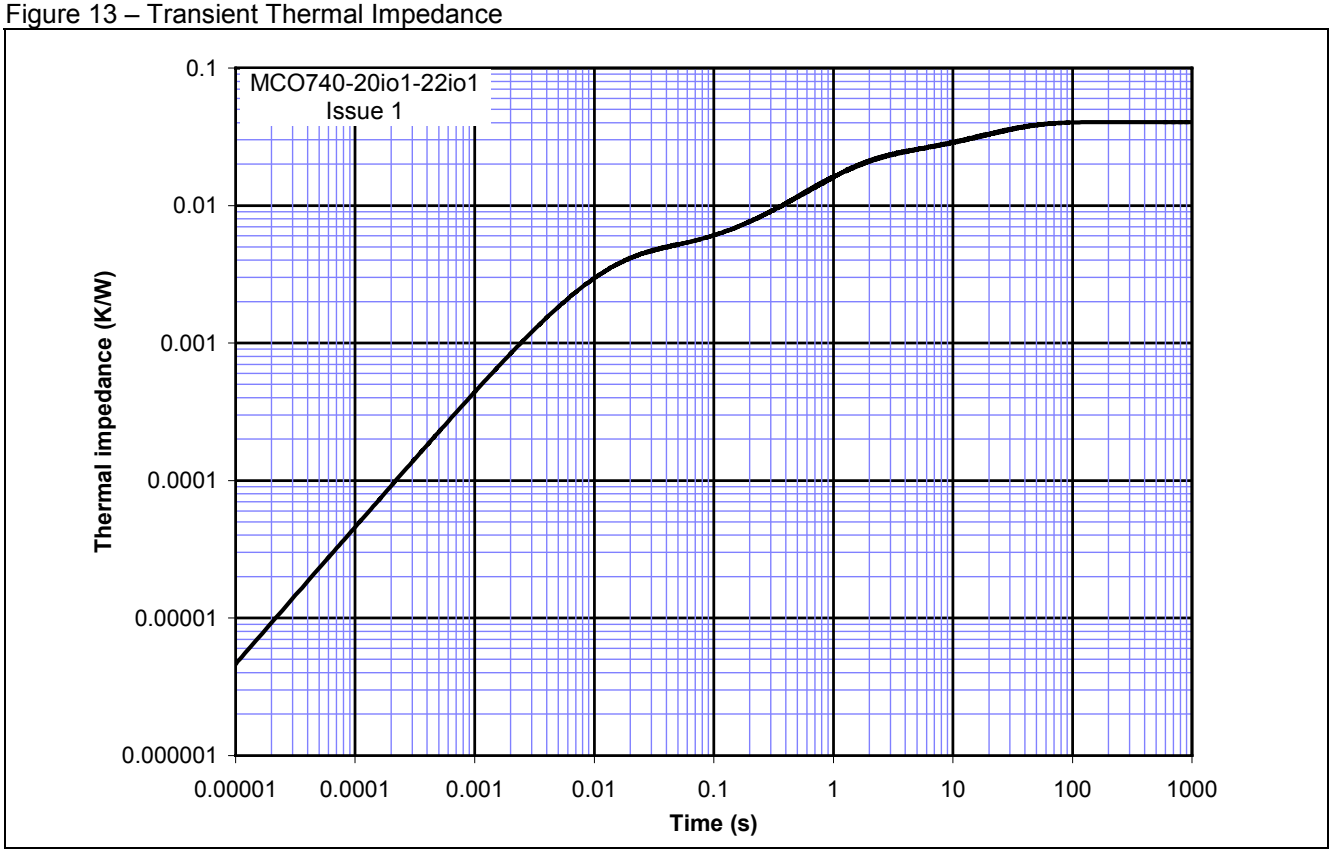
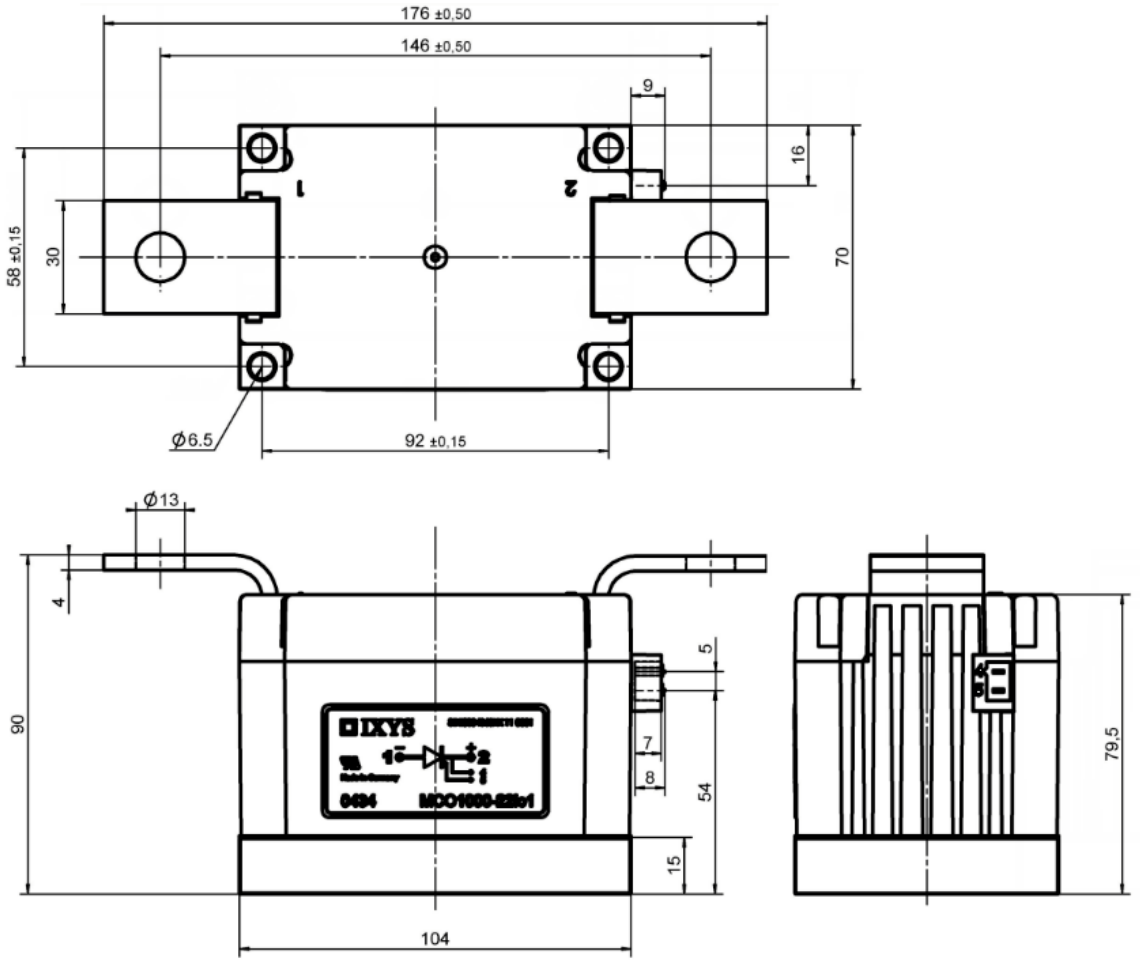


Figure 13 – Transient Thermal Impedance



Outline Drawing & Ordering Information



ORDERING INFORMATION (Please quote 11 digit code as below)

M	CO	740	♦♦	io	1
Fixed Type Code	Fixed Configuration code	Nominal Current Rating	Voltage code V_{RRM}/100 20-22	i = Critical dv/dt 1000 V/µs o = Typical turn-off time	Fixed Version Code

Typical order code: MCO740-20io1, 2000V V_{DRM}, V_{RRM} thyristor module

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